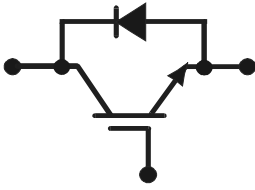


$V_{CE} = 1700\text{ V}$
 $I_C = 1800\text{ A}$

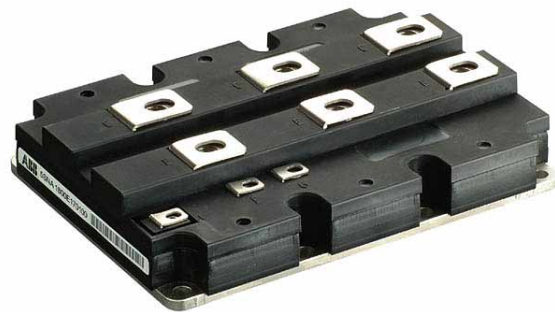
ABB HiPak™



IGBT Module
5SNA 1800E170100
PRELIMINARY

Doc. No. 5SYA 1554-01 Oct 03

- Low-loss, rugged SPT chip-set
- Smooth switching SPT chip-set for good EMC
- Industry standard package
- High power density
- AlSiC base-plate for high power cycling capability
- AlN substrate for low thermal resistance



Maximum rated values ¹⁾

Parameter	Symbol	Conditions	min	max	Unit
Collector-emitter voltage	V_{CES}	$V_{GE} = 0\text{ V}$		1700	V
DC collector current	I_C	$T_c = 80\text{ °C}$		1800	A
Peak collector current	I_{CM}	$t_p = 1\text{ ms}, T_c = 80\text{ °C}$		3600	A
Gate-emitter voltage	V_{GES}		-20	20	V
Total power dissipation	P_{tot}	$T_c = 25\text{ °C}$, per switch (IGBT)		13900	W
DC forward current	I_F			1800	A
Peak forward current	I_{FM}			3600	A
Surge current	I_{FSM}	$V_R = 0\text{ V}, T_{vj} = 125\text{ °C}$, $t_p = 10\text{ ms}$, half-sinewave		16500	A
IGBT short circuit SOA	t_{psc}	$V_{CC} = 1000\text{ V}, V_{CEMCHIP} \leq 1700\text{ V}$ $V_{GE} \leq 15\text{ V}, T_{vj} \leq 125\text{ °C}$		10	μs
Isolation voltage	V_{isol}	1 min, $f = 50\text{ Hz}$		4000	V
Junction temperature	T_{vj}			150	$^{\circ}\text{C}$
Junction operating temperature	$T_{vj(op)}$		-40	125	$^{\circ}\text{C}$
Storage temperature	T_{stg}		-40	125	$^{\circ}\text{C}$
Mounting torques	M_1	Base-heatsink, M6 screws	4	6	Nm
	M_2	Main terminals, M8 screws	8	10	

1) Maximum rated values indicate limits beyond which damage to the device may occur

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IGBT characteristic values

Parameter	Symbol	Conditions	min	typ	max	Unit
Collector (-emitter) breakdown voltage	$V_{(BR)CES}$	$V_{GE} = 0 \text{ V}$, $I_C = 10 \text{ mA}$, $T_{vj} = 25 \text{ }^\circ\text{C}$	1700			V
Collector-emitter ²⁾ saturation voltage	$V_{CE \text{ sat}}$	$I_C = 1800 \text{ A}$, $V_{GE} = 15 \text{ V}$		2.3	2.6	V
		$T_{vj} = 25 \text{ }^\circ\text{C}$				V
		$T_{vj} = 125 \text{ }^\circ\text{C}$		2.6	2.9	V
Collector cut-off current	I_{CES}	$V_{CE} = 1700 \text{ V}$, $V_{GE} = 0 \text{ V}$			12	mA
		$T_{vj} = 25 \text{ }^\circ\text{C}$				mA
		$T_{vj} = 125 \text{ }^\circ\text{C}$			120	mA
Gate leakage current	I_{GES}	$V_{CE} = 0 \text{ V}$, $V_{GE} = \pm 20 \text{ V}$, $T_{vj} = 125 \text{ }^\circ\text{C}$	-500		500	nA
Gate-emitter threshold voltage	$V_{GE(TO)}$	$I_C = 240 \text{ mA}$, $V_{CE} = V_{GE}$, $T_{vj} = 25 \text{ }^\circ\text{C}$	4.5		6.5	V
Gate charge	Q_{ge}	$I_C = 1800 \text{ A}$, $V_{CE} = 900 \text{ V}$, $V_{GE} = -15 \text{ V} \dots 15 \text{ V}$		15.1		μC
Input capacitance	C_{ies}	$V_{CE} = 25 \text{ V}$, $V_{GE} = 0 \text{ V}$, $f = 1 \text{ MHz}$, $T_{vj} = 25 \text{ }^\circ\text{C}$		166		nF
Output capacitance	C_{oes}			16.5		
Reverse transfer capacitance	C_{res}			6.98		
Turn-on delay time	$t_{d(on)}$	$V_{CC} = 900 \text{ V}$, $I_C = 1800 \text{ A}$, $R_G = 0.82 \text{ } \Omega$, $V_{GE} = \pm 15 \text{ V}$, $L_\sigma = 60 \text{ nH}$, inductive load	$T_{vj} = 25 \text{ }^\circ\text{C}$	270		ns
			$T_{vj} = 125 \text{ }^\circ\text{C}$	285		
Rise time	t_r	$V_{GE} = \pm 15 \text{ V}$, $L_\sigma = 60 \text{ nH}$, inductive load	$T_{vj} = 25 \text{ }^\circ\text{C}$	220		ns
			$T_{vj} = 125 \text{ }^\circ\text{C}$	230		
Turn-off delay time	$t_{d(off)}$	$V_{CC} = 900 \text{ V}$, $I_C = 1800 \text{ A}$, $R_G = 0.82 \text{ } \Omega$, $V_{GE} = \pm 15 \text{ V}$, $L_\sigma = 60 \text{ nH}$, inductive load	$T_{vj} = 25 \text{ }^\circ\text{C}$	855		ns
			$T_{vj} = 125 \text{ }^\circ\text{C}$	950		
Fall time	t_f	$V_{GE} = \pm 15 \text{ V}$, $L_\sigma = 60 \text{ nH}$, inductive load	$T_{vj} = 25 \text{ }^\circ\text{C}$	230		ns
			$T_{vj} = 125 \text{ }^\circ\text{C}$	240		
Turn-on switching energy	E_{on}	$V_{CC} = 900 \text{ V}$, $I_C = 1800 \text{ A}$, $V_{GE} = \pm 15$, $R_G = 0.82 \text{ } \Omega$, $L_\sigma = 60 \text{ nH}$, inductive load	$T_{vj} = 25 \text{ }^\circ\text{C}$	360		mJ
			$T_{vj} = 125 \text{ }^\circ\text{C}$	530		
Turn-off switching energy	E_{off}	$V_{CC} = 900 \text{ V}$, $I_C = 1800 \text{ A}$, $V_{GE} = \pm 15$, $R_G = 0.82 \text{ } \Omega$, $L_\sigma = 60 \text{ nH}$, inductive load	$T_{vj} = 25 \text{ }^\circ\text{C}$	530		mJ
			$T_{vj} = 125 \text{ }^\circ\text{C}$	670		
Short circuit current	I_{SC}	$t_{psc} \leq 10 \text{ } \mu\text{s}$, $V_{GE} = 15 \text{ V}$, $T_{vj} = 125 \text{ }^\circ\text{C}$, $V_{CC} = 1000 \text{ V}$, $V_{CEM \text{ CHIP}} \leq 1700 \text{ V}$		8500		A
Module stray inductance	$L_{\sigma \text{ CE}}$			10		nH
Resistance, terminal-chip	$R_{CC'+EE'}$		$T_C = 25 \text{ }^\circ\text{C}$	0.06		m Ω
			$T_C = 125 \text{ }^\circ\text{C}$	0.085		

2) Collector emitter saturation voltage is given at chip level

Diode characteristic values

Parameter	Symbol	Conditions	min	typ	max	Unit
Continuous forward voltage ³⁾	V_F	$I_F = 1800 \text{ A}$	$T_{vj} = 25 \text{ °C}$	1.65	2.0	V
			$T_{vj} = 125 \text{ °C}$		1.7	
Peak reverse recovery current	I_{RM}	$V_{CC} = 900 \text{ V},$ $I_F = 1800 \text{ A},$ $V_{GE} = \pm 15 \text{ V},$ $R_G = 0.82 \text{ } \Omega$ $L_\sigma = 60 \text{ nH}$ inductive load	$T_{vj} = 25 \text{ °C}$	1170		A
			$T_{vj} = 125 \text{ °C}$	1470		
Recovered charge	Q_{RR}	$V_{CC} = 900 \text{ V},$ $I_F = 1800 \text{ A},$ $V_{GE} = \pm 15 \text{ V},$ $R_G = 0.82 \text{ } \Omega$ $L_\sigma = 60 \text{ nH}$ inductive load	$T_{vj} = 25 \text{ °C}$	435		μC
			$T_{vj} = 125 \text{ °C}$	770		
Reverse recovery time	t_{rr}	$V_{CC} = 900 \text{ V},$ $I_F = 1800 \text{ A},$ $V_{GE} = \pm 15 \text{ V},$ $R_G = 0.82 \text{ } \Omega$ $L_\sigma = 60 \text{ nH}$ inductive load	$T_{vj} = 25 \text{ °C}$	550		ns
			$T_{vj} = 125 \text{ °C}$	870		
Reverse recovery energy	E_{rec}	$V_{CC} = 900 \text{ V},$ $I_F = 1800 \text{ A},$ $V_{GE} = \pm 15 \text{ V},$ $R_G = 0.82 \text{ } \Omega$ $L_\sigma = 60 \text{ nH}$ inductive load	$T_{vj} = 25 \text{ °C}$	300		mJ
			$T_{vj} = 125 \text{ °C}$	530		

3) Forward voltage is given at chip level

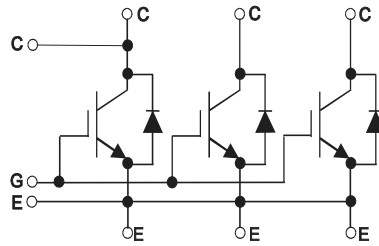
Thermal properties

Parameter	Symbol	Conditions	min	typ	max	Unit
IGBT thermal resistance junction to case	$R_{th(j-c)IGBT}$				0.009	K/W
Diode thermal resistance junction to case	$R_{th(j-c)DIODE}$				0.017	K/W
Thermal resistance case to heatsink	$R_{th(c-h)}$	per module, λ grease = $1\text{W/m} \times \text{K}$		0.006		K/W

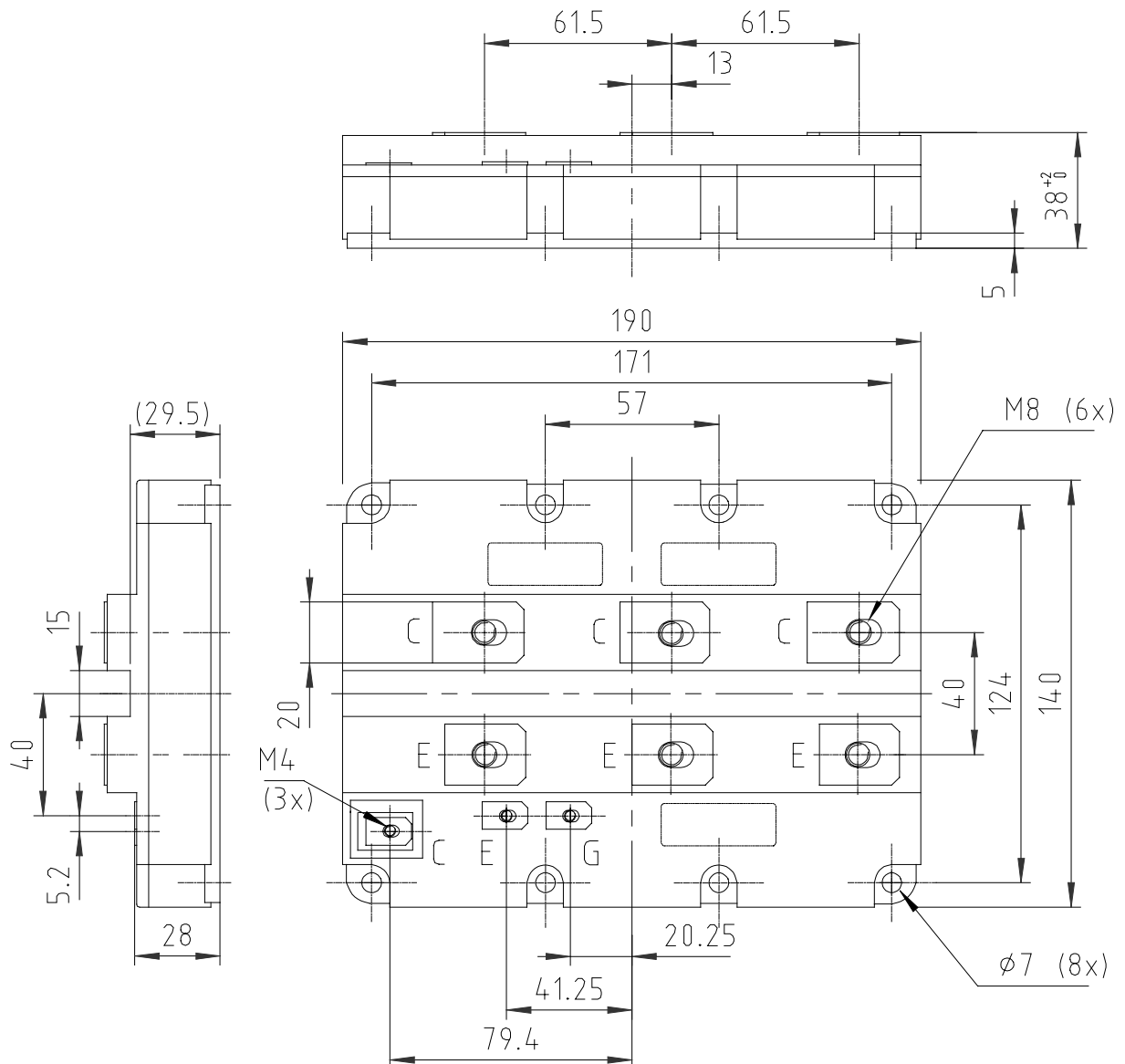
Mechanical properties

Parameter	Symbol	Conditions	min	typ	max	Unit
Dimensions	$L \times W \times H$	Typical , see outline drawing	190 × 140 × 38			mm
Clearance distance	D_C	according to IEC 60664-1 and EN 50124-1	Term. to base:	23		mm
			Term. to term:	19		
Surface creepage distance	D_{SC}	according to IEC 60664-1 and EN 50124-1	Term. to base:	33		mm
			Term. to term:	32		
Weight				1500		gr

Electrical configuration



Outline drawing



Note: all dimensions are shown in mm

This is an electrostatic sensitive device, please observe the international standard IEC 60747-1, chap. IX.

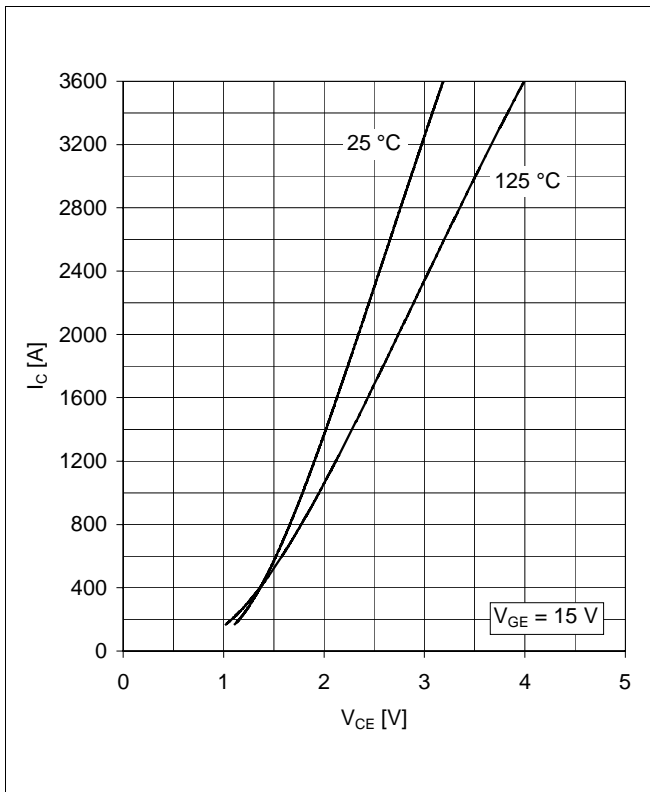


Fig. 1 Typical onstate characteristics, chip level

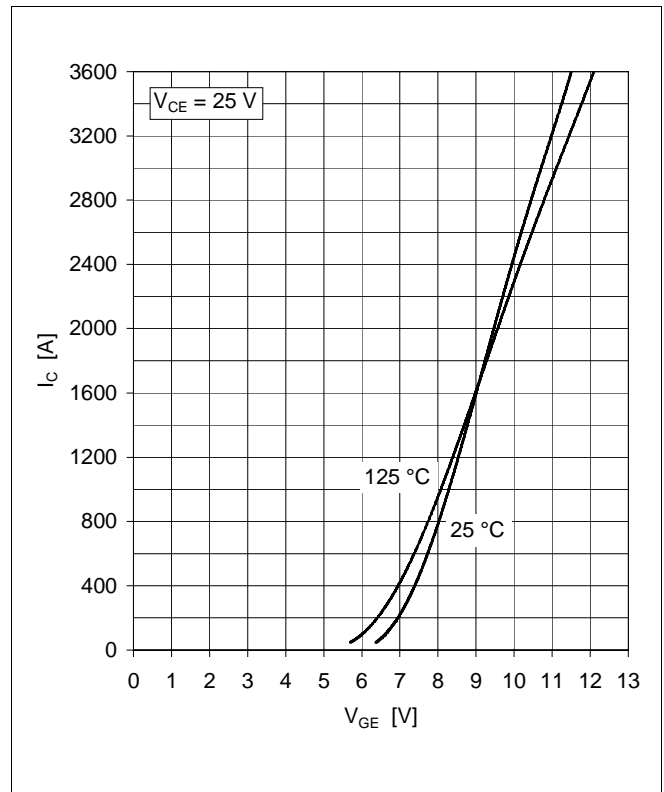


Fig. 2 Typical transfer characteristics, chip level

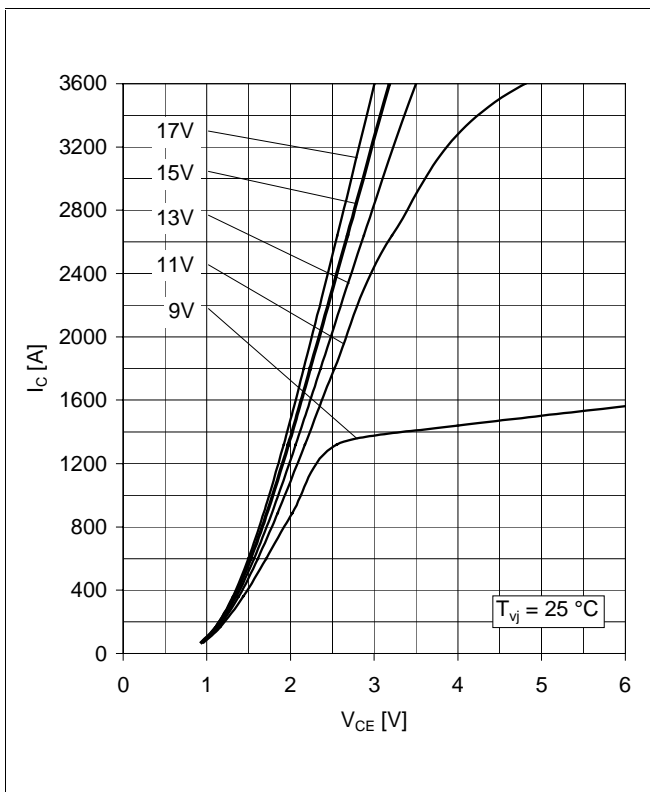


Fig. 3 Typical output characteristics, chip level

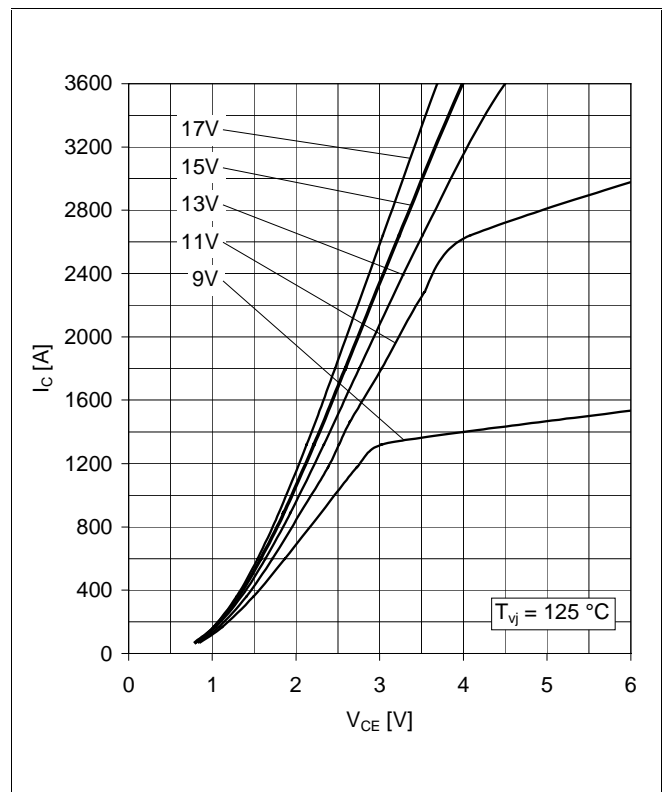


Fig. 4 Typical output characteristics, chip level

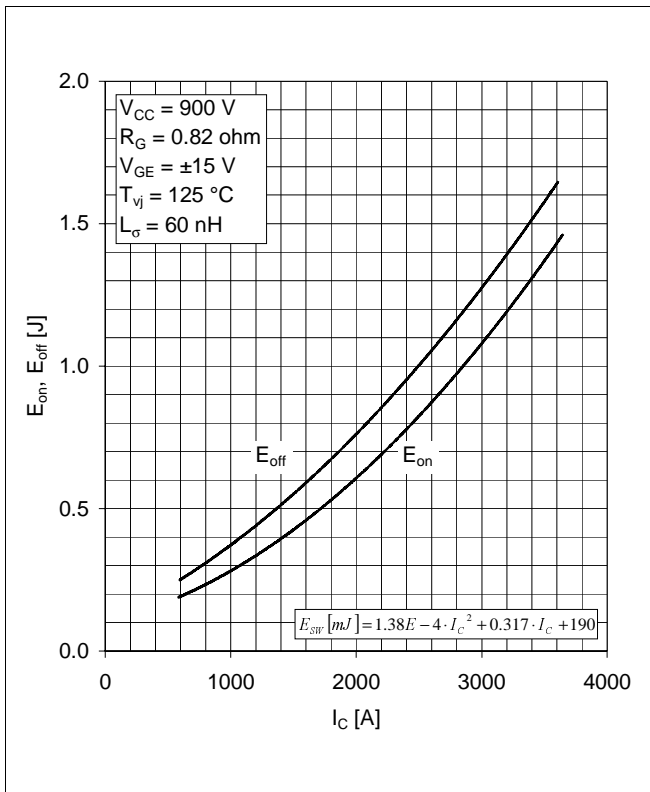


Fig. 5 Typical switching energies per pulse vs collector current

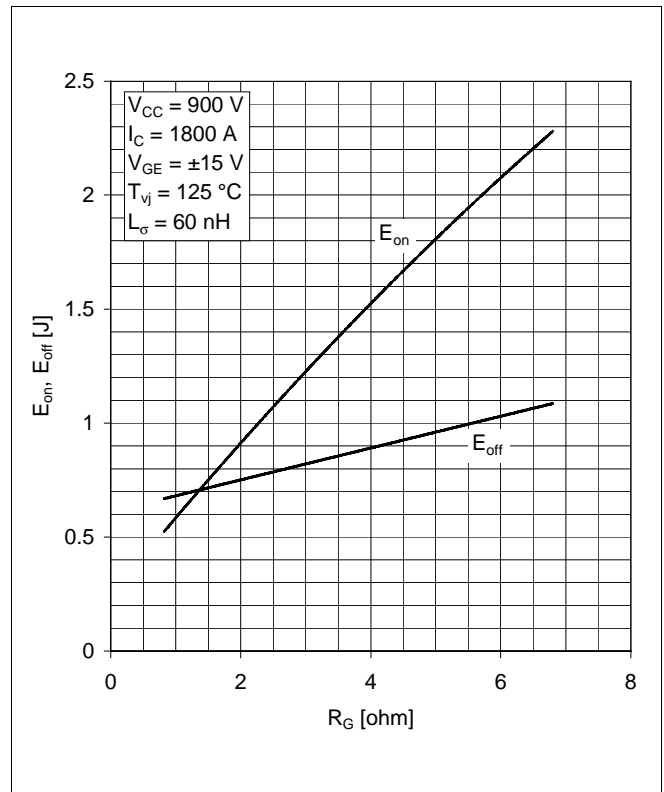


Fig. 6 Typical switching energies per pulse vs gate resistor

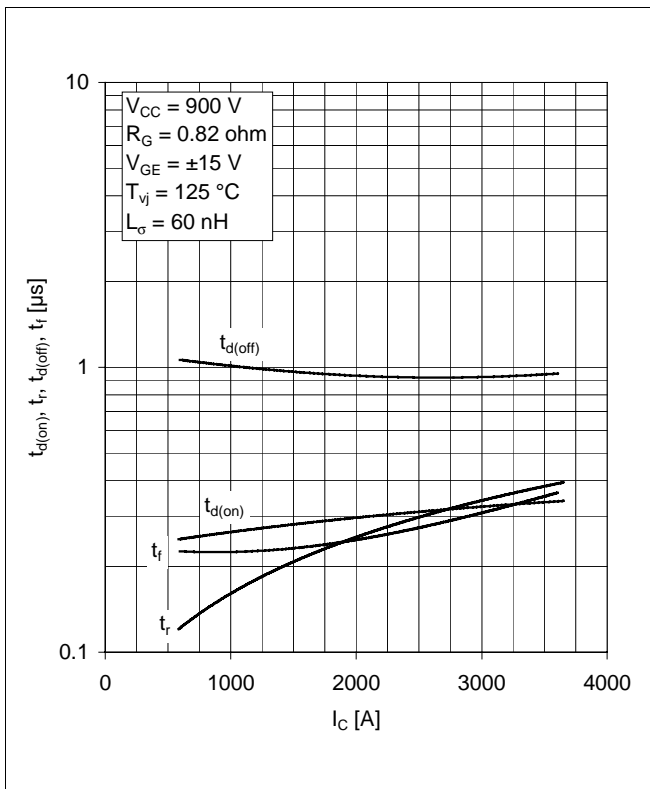


Fig. 7 Typical switching times vs collector current

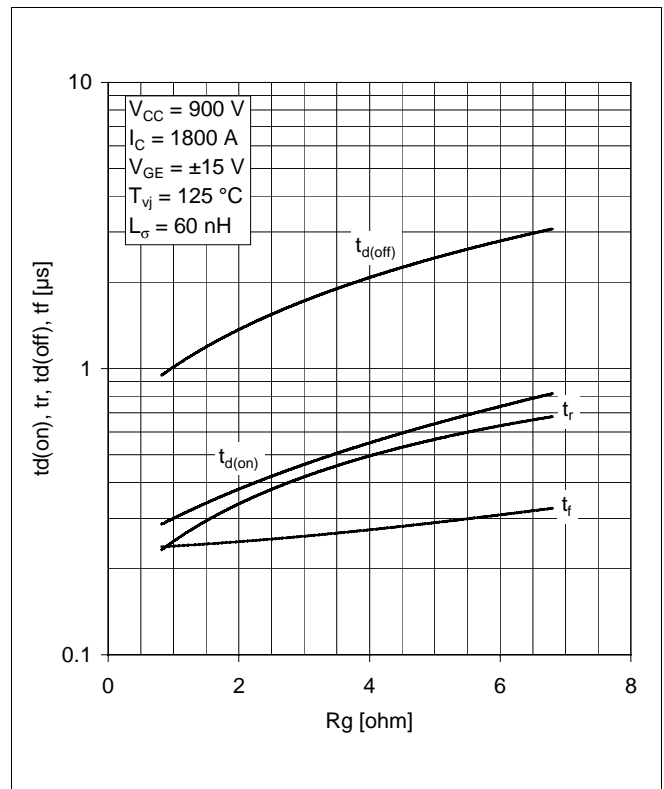


Fig. 8 Typical switching times vs gate resistor

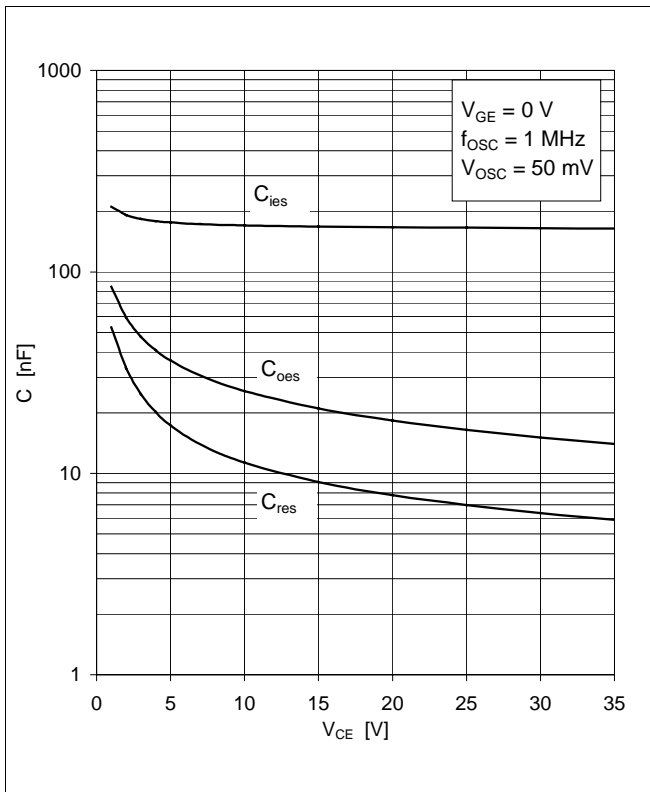


Fig. 9 Typical capacitances vs collector-emitter voltage

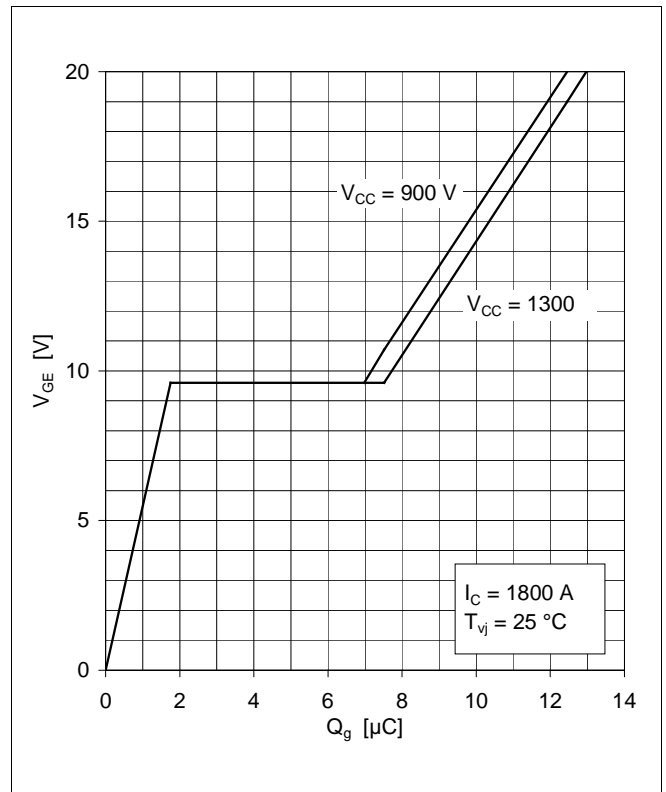


Fig. 10 Typical gate charge characteristics

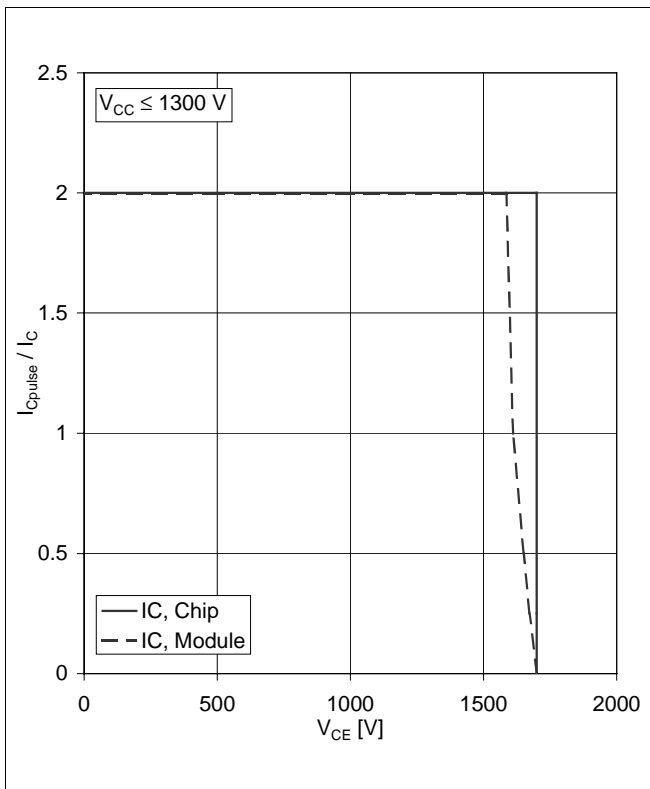


Fig. 11 Turn-off safe operating area (RBSOA)

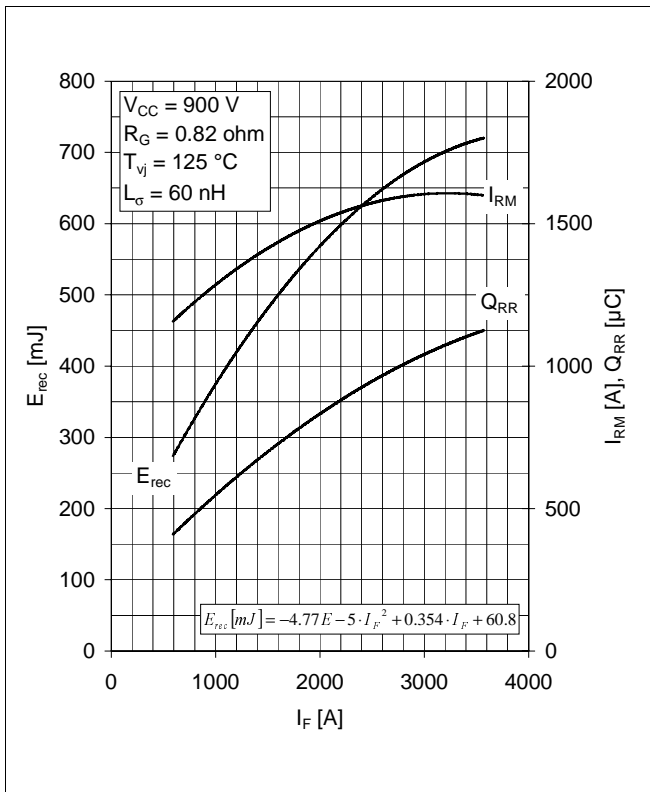


Fig. 12 Typical reverse recovery characteristics vs forward current

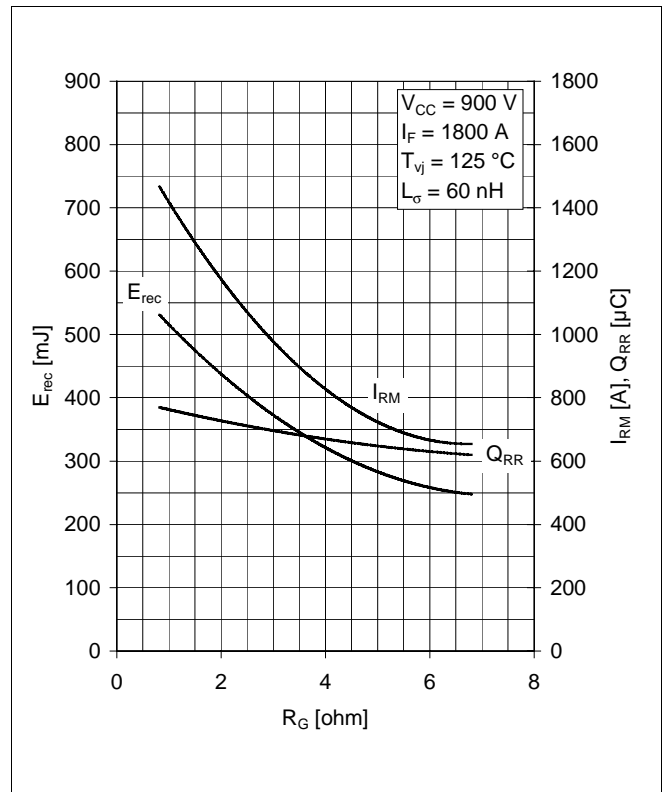


Fig. 13 Typical reverse recovery characteristics vs gate resistor

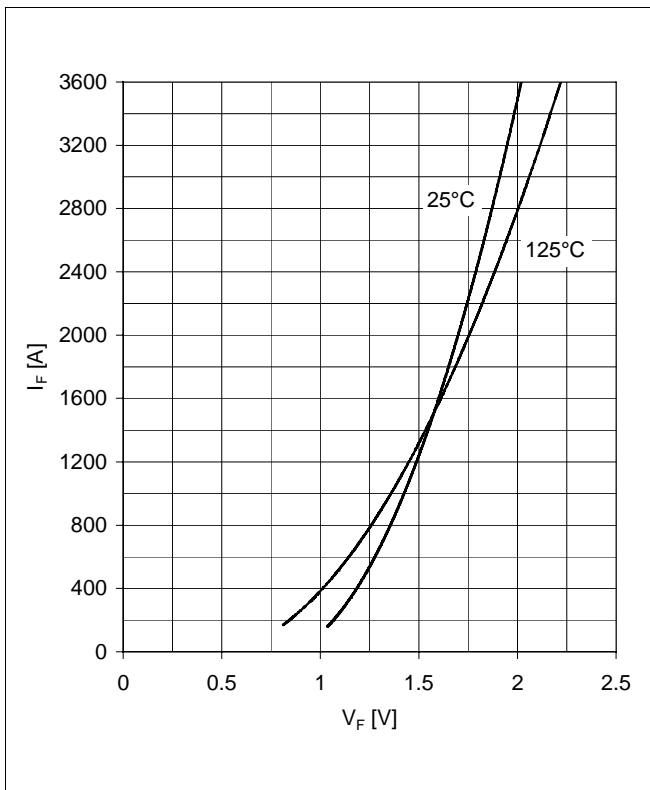


Fig. 14 Typical diode forward characteristics, chip level

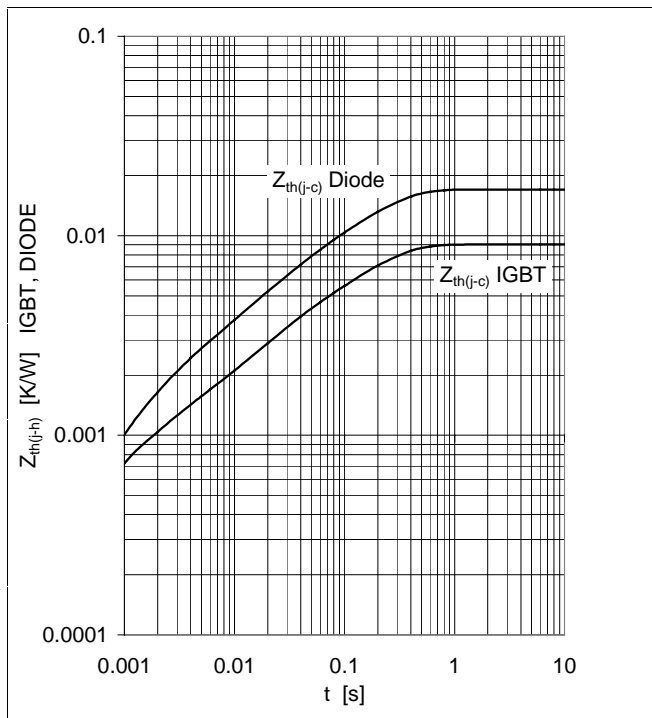


Fig. 15 Thermal impedance vs time

Analytical function for transient thermal impedance:

$$Z_{th\,JC}(t) = \sum_{i=1}^n R_i(1 - e^{-t/\tau_i})$$

	i	1	2	3	4	5
IGBT	R _i (K/kW)	5.97	1.99	0.619	0.465	
	τ _i (ms)	179	22	2.4	0.54	
DIODE	R _i (K/kW)	11.1	3.36	1.27	1.34	
	τ _i (ms)	189	30	7.4	1.4	

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